Search Notes

T	Application/Control No.	Applicant(s)/Patent under Reexamination		
	10/022,211	YOON, YEO-CH	EO-CHANG	
Π	Examiner	Art Unit		
	Hien X. Vo	2863		

SEARCHED							
Class	Subclass	Date	Examiner				
702	39	4/7/03	WIF				
713	323						
	322						
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315	8	·					
	364						
	368.1						
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INTERFERENCE SEARCHED							
Subclass	Dat	е	Examiner				
89	3/7/	17	WH				
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368.21							
371							
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	STRATEGY	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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315/8 315/368.21/37/1/4/						
348/E3.04						
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